

Search Notes

Application/Control No.

10/826,899

Examiner

Wai-Sing Louie

Applicant(s)/Patent under
Reexamination

JANG ET AL.

Art Unit

2814

SEARCHED

Class	Subclass	Date	Examiner
257	301,257,2 58,279	5/3/2005	WSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IC, MOSFET, DRAM, SRAM, non-volatile memory, EPROM, EEPROM, Ta2O5, HfO, Al2O3, SiO, SiN, high dielectric constant, low-k	5/3/2005	WSL